

FIG. 1

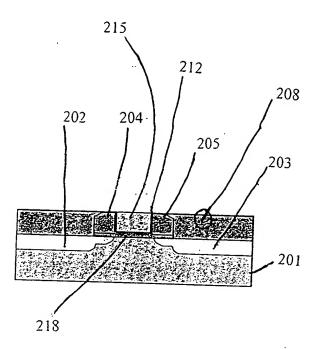


FIG. 2

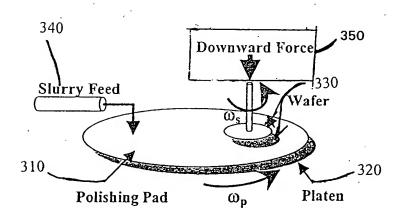


FIG. 3

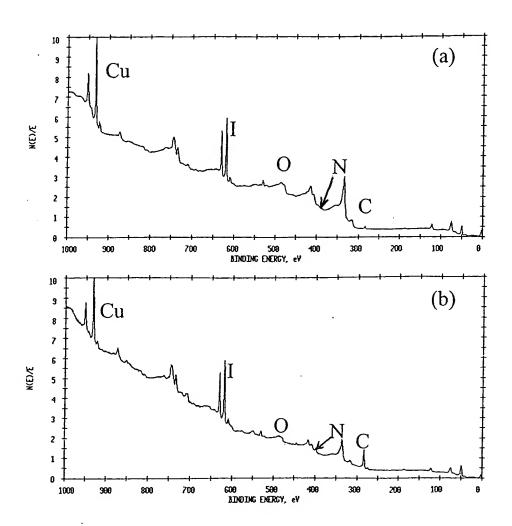


FIG. 4

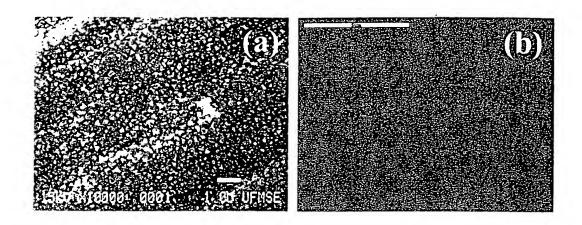


FIG. 5

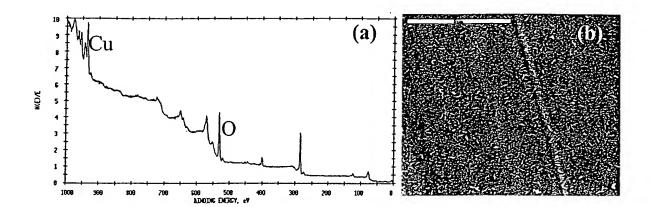


FIG. 6

	Concentration of iodine (N)				
	0.001	0.01	0.1		
Removal Rate (nm/min)	53	775.0	2716		
Selectivity with Cu/Ta	530	>4500	>5000		
RMS (nm)	1.06	1.98	2.13		
Scratches #/cm²	< 5	< 5	<5		

FIG. 7

	Concentration of Hydrogen Peroxide (%)				
	0.1%	1%	10%		
Removal Rate (nm/min)	5	27	6		
RMS (nm)	4.2	5.1	-		

FIG. 8

Pressure	2.7 psi	4.3 psi	6.7 psi
Removal Rate (nm/min)	298	335	425
Selectivity Cu/Ta	>3000	>3000	>3000
Surface Roughness (nm)	1.06	1.4	2.0
Scratches (#cm²)	<5	< 5	<5

FIG. 9

	0.01 N iodine						
	pH 4	pH 6	pH 8	pH 10	pH 12		
Removal Rate (nm/min)	1210	909	1023	756	23		
Selectivity (Ta)	4000	>4000	>4000	>3000	>200		

FIG. 10

	Concentration of Particles				
	No particle	5 wt.%			
Removal Rate (nm/min)	71	114	151		
Selectivity	>1000	> 200	>200		

FIG. 11

Effect of small amount of silica in iodine based solution

	Concentration of silica particle					
	No particle	0.01 wt.%	0.1 wt.%	1 wt%		
Removal Rate (nm/min)	50.4	80.2	153.6	333.5		
Selectivity on Cu/Ta	7200	529	13	8.0		
Scratches (#/cm ²)	0	0	1-2	5		

FIG. 12

The effect of inhibitors in iodine solution (pH 4 and 2.7 psi)

	0.01 N I ₂						
	No BTA			TTA			_
	inhibitor	1 mM	5 mM	10 mM	1 mM	5 mM	10 mM
Removal Rate (nm/min)	775.0	945.1	56.3	58.4	100.1	106.9	51.8
STD	7.6	14.9	16.6	16.2	27.2	13.2	7.3

The effect of surfactants on removal rate (nm/min) of copper in iodine solution (pH 4 and 6.7 psi)

	10 mN I ₂									
	No	SAS			Triton X-100					
	inhibitor	.5 mM	2 mM	5 mM	10mM	20 mM	1 mM	2 mM	3 mM	5 mM
RR (nm/min)	1210.0	1080.9	1040.0	975.7	524.7	514.0	977.5	189.0	129.7	29.5
STD	33.5	55.1	11.6	62.5	34.1	11.5	43.4	30.4	21.2	24.2

The static removal rate (nm/min) of copper in iodine based solutions (pH 4)

		10 mN iodine					
		No additive	5 mM BTA	10 mM SAS			
	4	64.9 ± 2.65	2.8 ± 0.4	39.6 ± 4.3			
pН	6	63.4 ± 2.37	1.1 ± 0.4	65.2 ± 10.1			
P	8	48.7 ± 2.4	-1.4 ± 0.7	28.9 ± 0.4			
	9	35.2 ± 1.3	-0.3 ± 0.5	27.7 ± 0.4			

FIG. 13

	0.01 N I ₂ , 10 mM TTA					
	No salt KI			NH₄CI		
		0.001 M	0.01 M	0.01 M	0.1 M	
Removal Rate (nm/min)	52	66	92	34	32	

FIG. 14

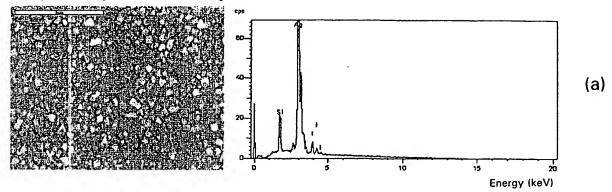
Effect of succinic acid/citric acid added in 10 mN Iodine and 5 mM BTA/TTA on CMP performance

	$10^{-2} \text{ N I}_2,$	5 mM BTA	10^{-2} N I_2	, 5 mM TTA	10 ⁻² N I ₂ , 5 mM BTA		
	Succinic Acid		Succinic Acid		Citric Acid		
	0.1 M	0.2 M	0.1 M	0.2M	0.1 M	0.2 M	
Removal Rate (nm/min)	33.5	37.4	36.6	47.0	295.1	432.5	
STD	12.5	1.9	10.9	6.1	26.6	5.0	
SRR (nm/min)	3.2	3.9	2.7	3.1	11.7	18.3	

FIG. 15

SEM (x10k) pictures and EDS of AgI

Slurry chemistry: 10 mN iodine at pH4



Slurry Chemistry: 10 mN iodine and 20 mM BTA at pH 4

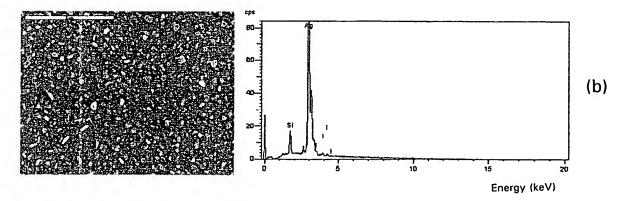


FIG. 16